

## FULLY PROTECTED HIGH SIDE POWER MOSFET SWITCH

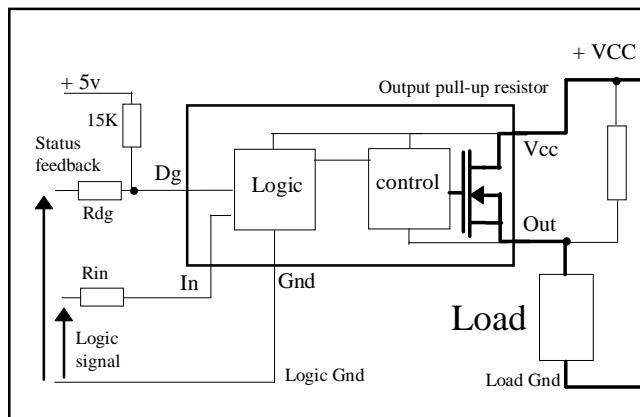
### Features

- Over temperature protection (with auto-restart)
- Short-circuit protection (current limit)
- Active clamp
- E.S.D protection
- Status feedback
- Open load detection
- Logic ground isolated from power ground

### Description

The IPS521G is a fully protected five terminal high side switch with built in short circuit, over-temperature, ESD protection, inductive load capability and diagnostic feedback. The output current is controlled when it reaches  $I_{lim}$  value. The current limitation is activated until the thermal protection acts. The over-temperature protection turns off the high side switch if the junction temperature exceeds  $T_{shutdown}$ . It will automatically restart after the junction has cooled 7°C below  $T_{shutdown}$ . A diagnostic pin is provided for status feedback of short-circuit, over-temperature and open load detection. The double level shifter circuitry allows large offsets between the logic ground and the load ground.

### Typical Connection



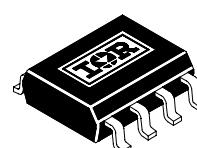
### Product Summary

$R_{ds(on)}$	100mW (max)
$V_{clamp}$	50V
$I_{Limit}$	10A
$T_{shutdown}$	165°C
$V_{open\ load}$	3V

### Truth Table

Op. Conditions	In	Out	Dg
Normal	H	H	H
Normal	L	L	L
Open load	H	H	H
Open load	L	H	H
Over current	H	L (limiting)	L
Over current	L	L	L
Over-temperature	H	L (cycling)	L
Over-temperature	L	L	L

### Available Package



8 Lead SOIC - IPS521G

## Absolute Maximum Ratings

Absolute maximum ratings indicates sustained limits beyond which damage to the device may occur. All voltage parameters are referenced to GROUND lead. ( $T_j = 25^\circ\text{C}$  unless otherwise specified).

Symbol	Parameter	Min.	Max.	Units	Test Conditions
$V_{\text{out}}$	Maximum output voltage	$V_{\text{cc}}-50$	$V_{\text{cc}}+0.3$	V	
$V_{\text{offset}}$	Maximum logic ground to load ground offset	$V_{\text{cc}}-50$	$V_{\text{cc}}+0.3$		
$V_{\text{in}}$	Maximum Input voltage	-0.3	7		
$I_{\text{in, max}}$	Maximum positive IN current	-1	10	mA	
$V_{\text{dg}}$	Maximum diagnostic output voltage	-0.3	7	V	
$I_{\text{dg, max}}$	Maximum diagnostic output current	-1	10	mA	
$I_{\text{sd cont.}}$	Diode max. permanent current (1) ( $r_{\text{th}} = 62^\circ\text{C/W}$ )	—	1.4	A	
$I_{\text{sd pulsed}}$	Diode max. pulsed current (1)	—	10		
ESD1	Electrostatic discharge voltage (Human Body)	—	4000	V	C=100pF, R=1500W,
ESD2	Electrostatic discharge voltage (Machine Model)	—	500		C=200pF, R=0W,
Pd	Maximum power dissipation <sup>(1)</sup> ( $r_{\text{th}}=125^\circ\text{C/W}$ )	—	1		
$T_j \text{ max.}$	Max. storage & operating junction temp.	-40	+150	°C	

## Thermal Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Rth1	Thermal resistance with standard footprint	—	100	125	°C/W	8 Lead SOIC
Rth2	Thermal resistance with 1" square footprint	—	—	80	°C/W	

## Recommended Operating Conditions

These values are given for a quick design. For operation outside these conditions, please consult the application notes.

Symbol	Parameter	Min.	Max.	Units
Vcc	Continuous Vcc voltage	5.5	35	
VIH	High level input voltage	4	5.5	V
VIL	Low level input voltage	-0.3	0.9	
Iout	Continuous output current (TAmbient = 85°C, Tj = 125°C, Rth = 100°C/W)	—	1.6	A
Rin	Recommended resistor in series with IN pin	10	20	kW
Rdg	Recommended resistor in series with DG pin	10	20	

(1) Limited by junction temperature (pulsed current limited also by internal wiring)

## Static Electrical Characteristics

( $T_j = 25^\circ\text{C}$ ,  $V_{cc} = 14\text{V}$  unless otherwise specified.)

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$R_{ds(on)}$ @ $T_j=25^\circ\text{C}$	ON state resistance $T_j = 25^\circ\text{C}$	—	80	100	mW	$V_{in} = 5\text{V}$ , $I_{out} = 5\text{A}$
$R_{ds(on)}$ ( $V_{cc}=6\text{V}$ )	ON state resistance @ $V_{cc} = 6\text{V}$	—	80	—		$V_{in} = 5\text{V}$ , $I_{out} = 2.5\text{A}$
$R_{ds(on)}$ @ $T_j=150^\circ\text{C}$	ON state resistance $T_j = 150^\circ\text{C}$	—	125	—		$V_{in} = 5\text{V}$ , $I_{out} = 5\text{A}$
$V_{cc\ oper.}$	Operating voltage range	5.5	—	35	V	
$V_{\text{clamp}\ 1}$	$V_{cc}$ to OUT clamp voltage 1	50	56	—		$I_d = 10\text{mA}$ (see Fig.1 & 2)
$V_{\text{clamp}\ 2}$	$V_{cc}$ to OUT clamp voltage 2	—	58	65		$I_d = I_{sd}$ (see Fig.1 & 2)
$V_f$	Body diode forward voltage	—	0.9	1.2		$I_d = 2.5\text{A}$ , $V_{in} = 0\text{V}$
$I_{cc\ off}$	Supply current when OFF	—	16	50	mA	$V_{in} = 0\text{V}$ , $V_{out} = 0\text{V}$
$I_{cc\ on}$	Supply current when ON	—	0.7	2	mA	$V_{in} = 5\text{V}$
$I_{cc\ ac}$	Ripple current when ON (AC RMS)	—	20	—	mA	$V_{in} = 5\text{V}$
$V_{dg1}$	Low level diagnostic output voltage	—	0.15	—	V	$I_{dg} = 1.6\text{ mA}$
$I_{ol}$	Output leakage current	—	50	—	mA	$V_{out} = 6\text{V}$
$I_{ol}$	Output leakage current	0	—	25		$V_{out} = 0\text{V}$
$I_{dg\ leakage}$	Diagnostic output leakage current	—	—	10		$V_{dg} = 5.5\text{V}$
$V_{ih}$	IN high threshold voltage	—	2.0	2.5	V	
$V_{il}$	IN low threshold voltage	1	1.8	—		
$I_{in, \text{on}}$	On state IN positive current	—	70	—	mA	$V_{in} = 5\text{V}$

## Switching Electrical Characteristics

$V_{cc} = 14\text{V}$ , Resistive Load =  $2.8\text{W}$ ,  $T_j = 25^\circ\text{C}$ , (unless otherwise specified).

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$T_{on}$	Turn-on delay time	—	10	—	μs	See figure 3
$T_{r1}$	Rise time to $V_{out} = V_{cc} - 5\text{V}$	—	25	—		
$T_{r2}$	Rise time to $V_{out} = 90\%$ of $V_{cc}$	—	130	—		
$dV/dt\ (\text{on})$	Turn ON $dV/dt$	—	0.7	—		
$E_{on}$	Turn ON energy	—	2000	—	μJ	
$T_{off}$	Turn-off delay time	—	35	—	μs	See figure 4
$T_f$	Fall time to $V_{out} = 10\%$ of $V_{cc}$	—	25	—		
$dV/dt\ (\text{off})$	Turn OFF $dV/dt$	—	0.9	—		
$E_{off}$	Turn OFF energy	—	600	—	μJ	
$T_{diag}$	$V_{out}$ to $V_{diag}$ propagation delay	—	tbd	—	μs	

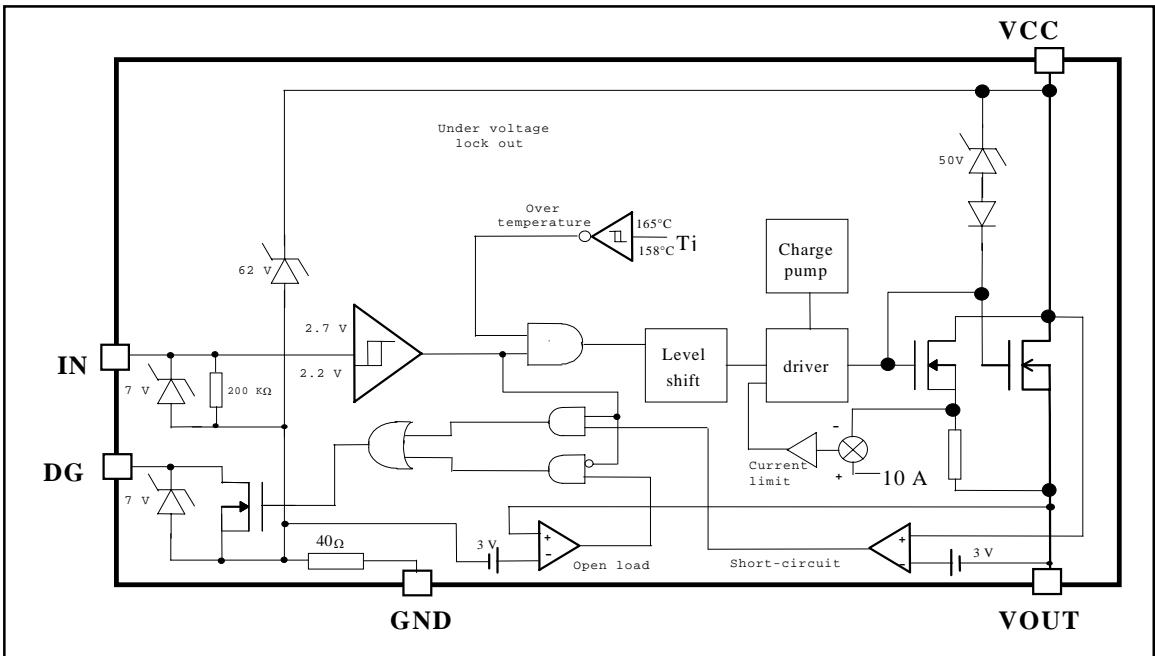
## Protection Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Ilim	Internal current limit	—	10	—	A	V <sub>out</sub> = 0V
Tsd+	Over-temp. positive going threshold	—	165	—	°C	See fig. 2
Tsd-	Over-temp. negative going threshold	—	158	—	°C	See fig. 2
Vsc	Short-circuit detection voltage (3)	—	3	—	V	See fig. 2
Vopen load	Open load detection threshold	—	3	—	V	

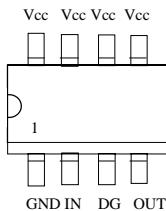
(3) Referenced to V<sub>CC</sub>

## Functional Block Diagram

All values are typical

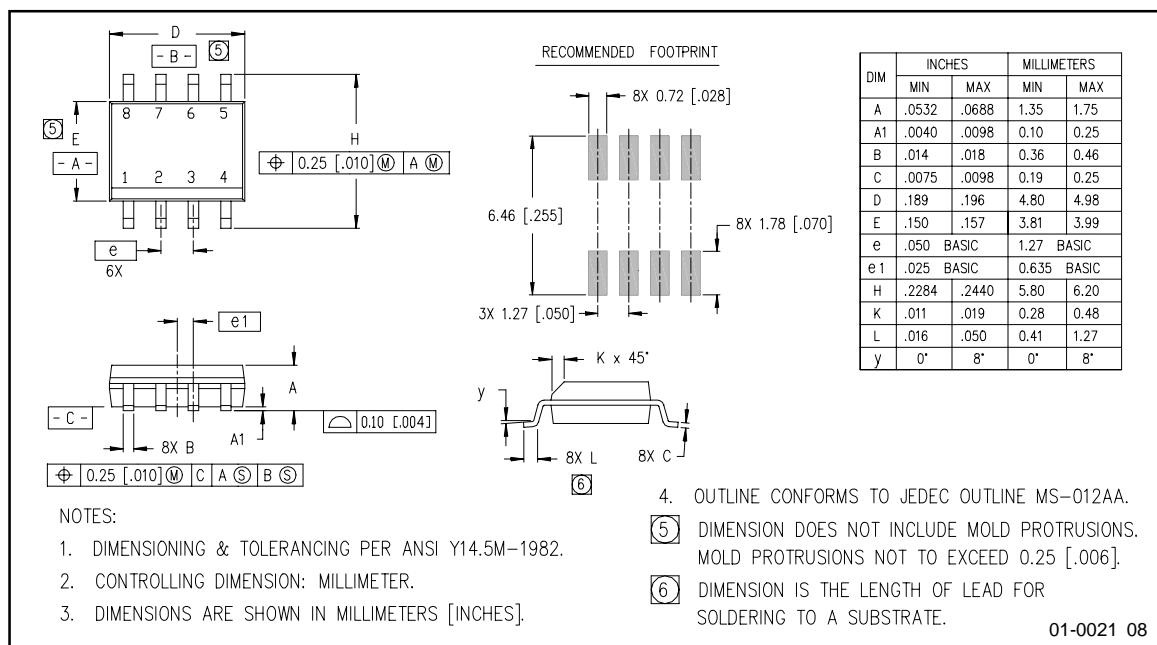


## Lead Assignments



8 Lead SOIC

## Case Outline - 8 Lead SOIC



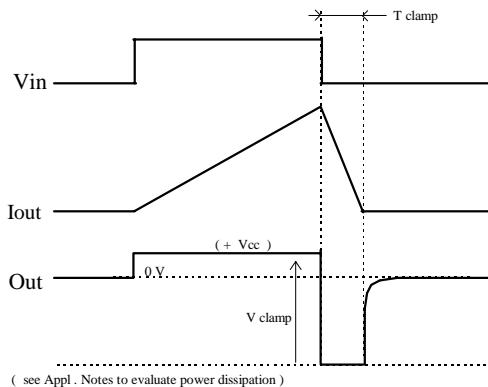


Figure 1 - Active clamp waveforms

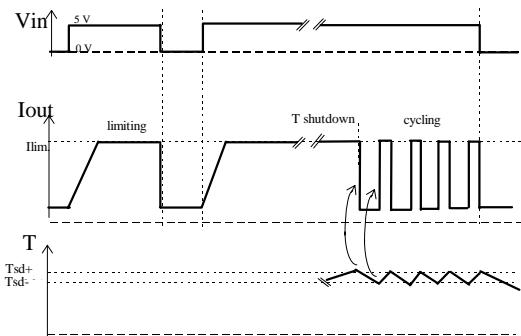


Figure 2 - Protection timing diagram

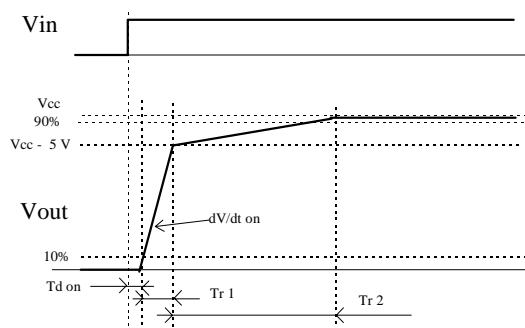


Figure 3 - Switching times definition (turn-on)

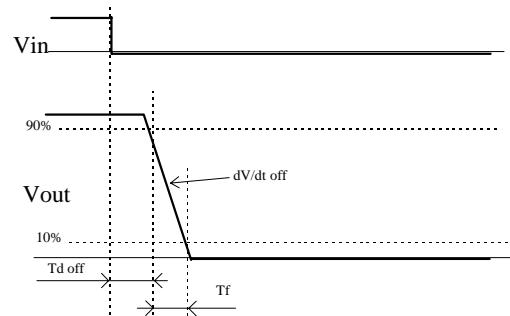


Figure 4 - Switching times definition (turn-off)

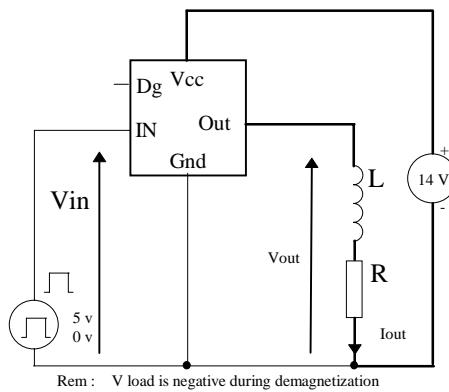


Figure 5 - Active clamp test circuit

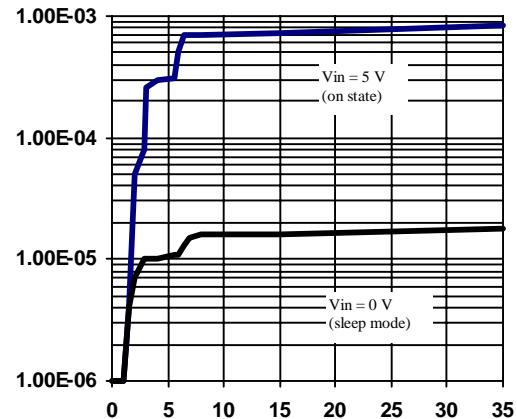


Figure 6 -  $I_{cc}$  (mA) Vs  $V_{cc}$  (V)

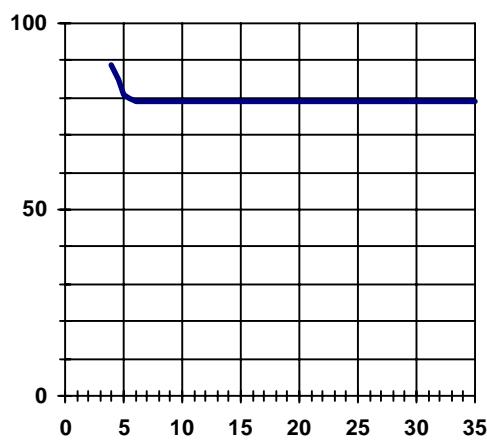


Figure 7 -  $R_{ds(on)}$  (mW) Vs  $V_{cc}$  (V)

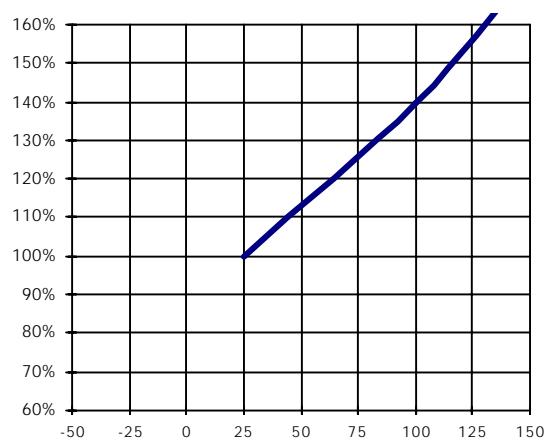


Figure 8 - Normalized  $R_{ds(on)}$  Vs  $T_j$  (°C)

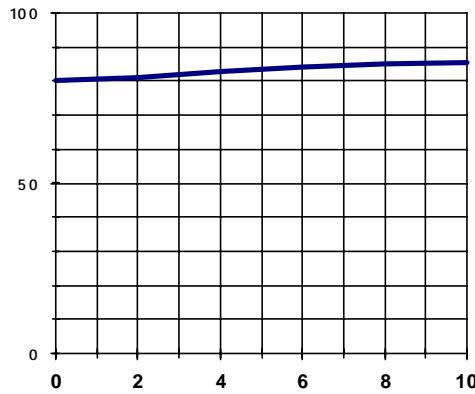


Figure 9 -  $R_{ds(on)}$  (mΩ) Vs  $I_{out}$  (A)

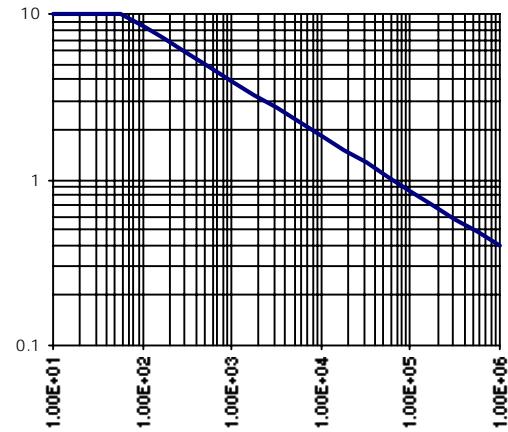


Figure 10 - Max.  $I_{out}$  (A) Vs Load Inductance (uH)

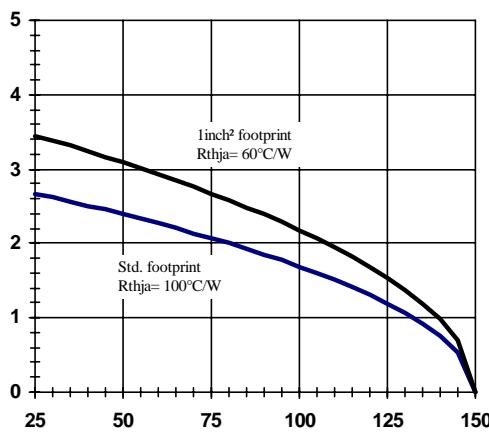


Figure 11 - Max load current (A) Vs  $T_{amb}$  (°C)

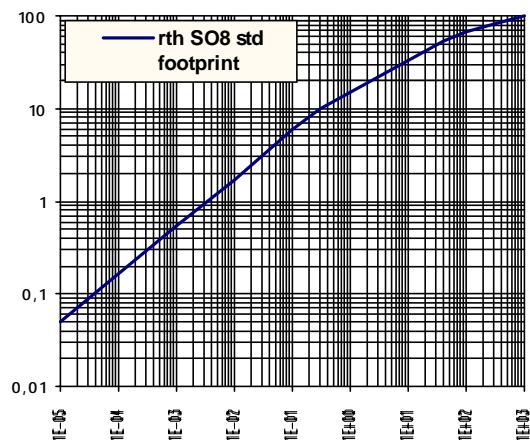


Figure 12 - Transient Thermal Impedance (°C/W)  
Vs Time (s)

International  
**IR** Rectifier

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